

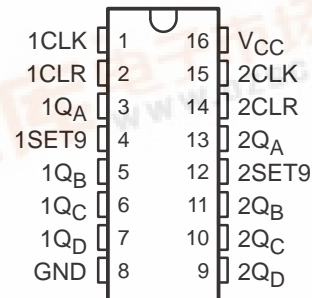
- **Dual Versions of the SN54LS90 and SN74LS90 Counters**
- **Individual Clock, Direct Clear, and Set-to-9 Inputs for Each Decade Counter**
- **Dual Counters Can Significantly Improve System Densities as Package Count Can Be Reduced by 50%**
- **Maximum Count Frequency of 25 MHz . . . 35 MHz Typical**
- **Buffered Outputs Reduce Possibility of Collector Commutation**
- **Package Options Include Plastic Small-Outline (D) Packages, Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs**

description

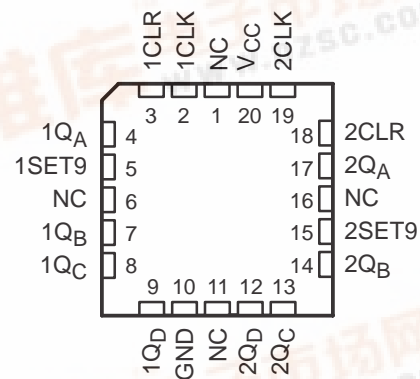
Each of these monolithic circuits contains eight master-slave flip-flops and additional gating to implement two individual 4-bit decade counters in a single package. Each decade counter has individual clock (1CLK, 2CLK), clear (1CLR, 2CLR), and set-to-9 (1SET9, 2SET9) inputs. BCD count sequences of any length up to divide-by-100 can be implemented with a single 'LS490 device. Buffering on each output is provided to significantly reduce susceptibility to collector commutation. All inputs are diode clamped to reduce the effects of line ringing. The counters have parallel outputs from each counter stage so that submultiples of the input count frequency are available for system timing signals.

The SN54LS490 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74LS490 is characterized for use in industrial systems operating from 0°C to 70°C .

SN54LS490 . . . J OR W PACKAGE
SN74LS490 . . . D OR N PACKAGE
(TOP VIEW)



SN54LS490 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

CLEAR/SET-TO-9 FUNCTION TABLE
(each counter)

INPUTS		OUTPUTS			
CLR	SET9	QA	QB	QC	QD
H	L	L	L	L	L
L	H	H	L	L	H
L	L	Count			

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

SN54LS490, SN74LS490

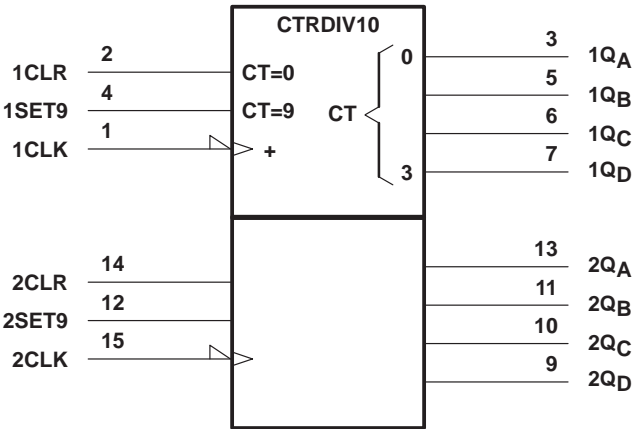
DUAL 4-BIT DECADE COUNTERS

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BCD COUNT SEQUENCE
(each counter)

COUNT	OUTPUTS			
	Q _D	Q _C	Q _B	Q _A
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H

logic symbol†

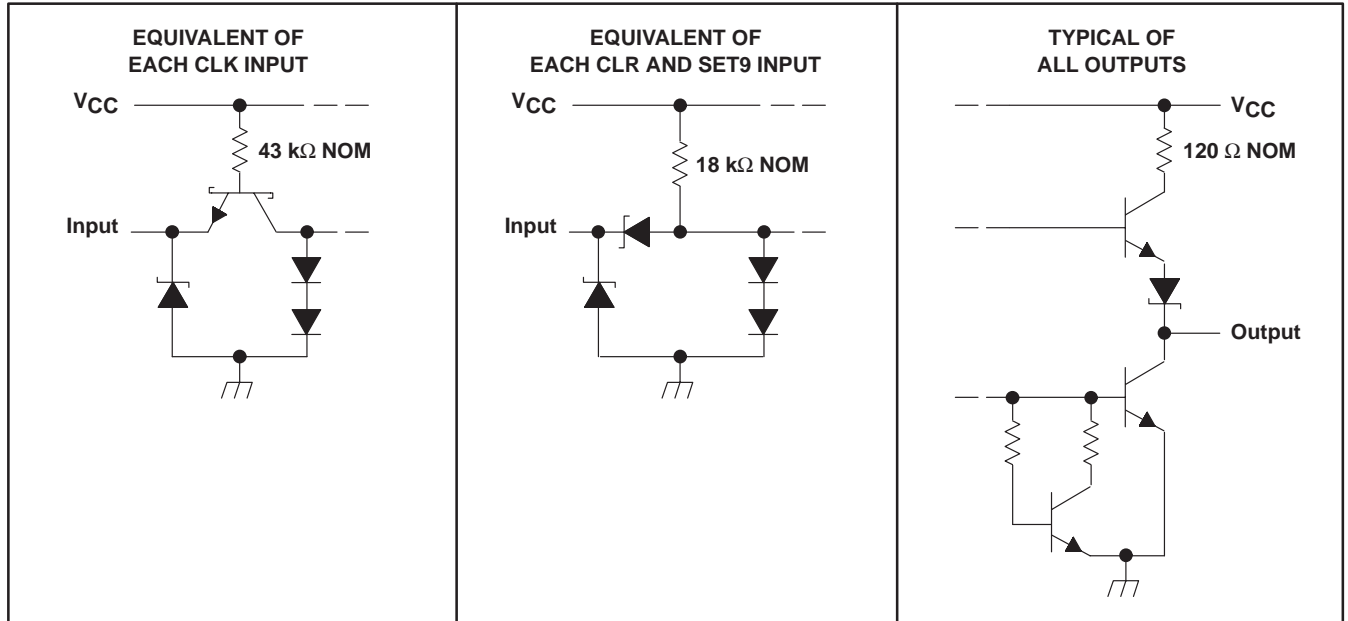


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the D, J, N, and W packages.

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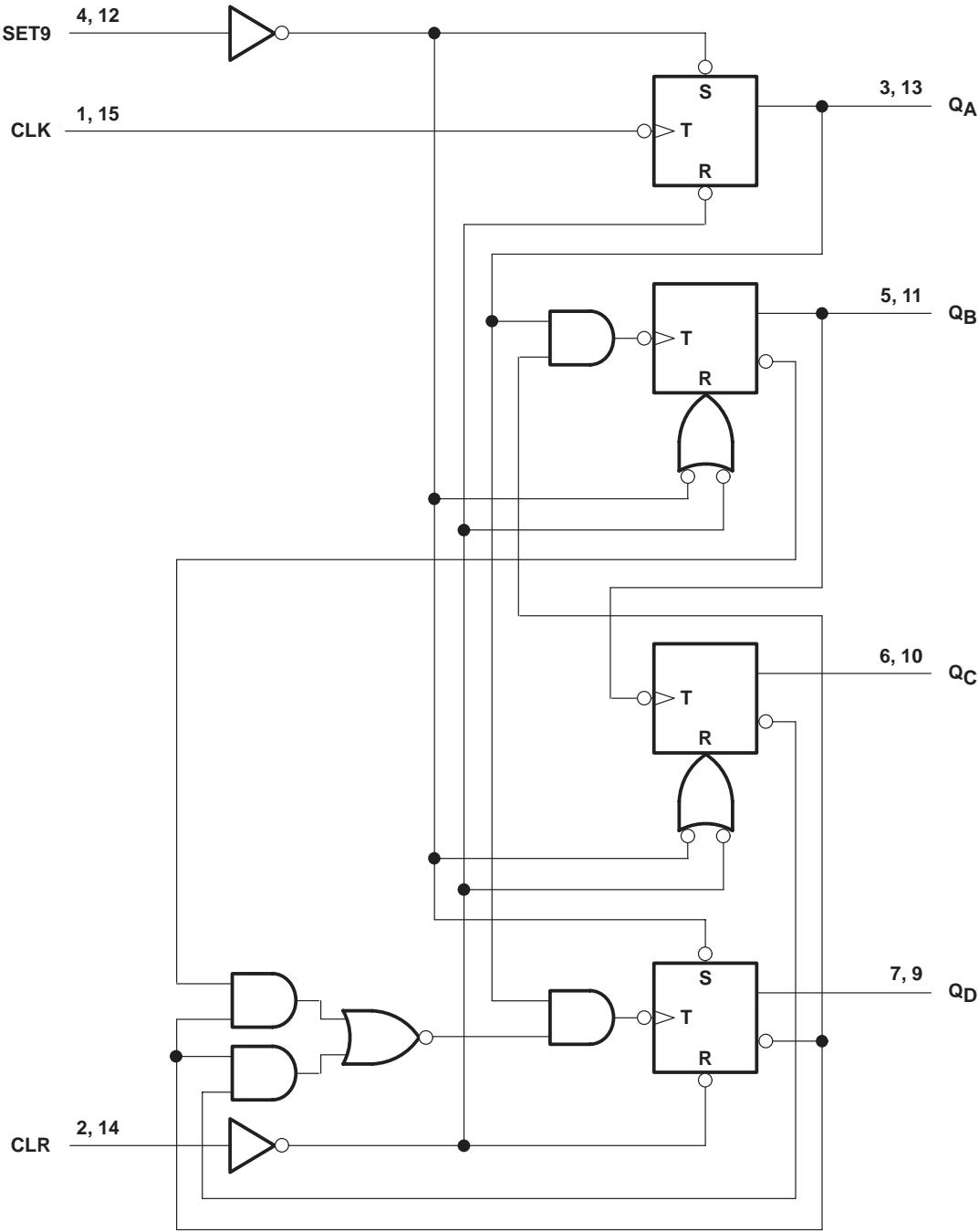
schematics of inputs and outputs



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logic diagram (each counter)



Pin numbers shown are for the D, J, N, and W packages.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage, V_{CC} (see Note 1)	–0.5 V to 7 V
Clear and set-to-9 voltage	–0.5 V to 7 V
Clock input voltage	–0.5 V to 5.5 V
Package thermal impedance, θ_{JA} (see Note 2): D package	113°C/W
N package	78°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. Voltage values are with respect to network ground terminal.
2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

		SN54LS490			SN74LS490			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
I_{OH}	High-level output current			–400			–400	μA
I_{OL}	Low-level output current			4			8	mA
f_{count}	Count frequency	0		25	0		25	MHz
t_w	Pulse width (any input)	20			20			ns
t_{su}	Clear or set-to-9 inactive-state setup time	25	\downarrow		25	\downarrow		ns
T_A	Operating free-air temperature	–55		125	0		70	°C

[‡] The arrow (\downarrow) indicates that the falling edge of the clock pulse is used for reference.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN74LS490			SN74LS490			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.7			0.8	V
V_{IK}	Input clamp voltage	$V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$			-1.5			-1.5	V
V_{OH}	High-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = V_{IL \text{ max}}$	2.5	3.4		2.7	3.4		V
V_{OL}	Low-level output voltage	$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = V_{IL \text{ max}}, I_{OL} = 4 \text{ mA}$		0.25	0.4		0.25	0.4	V
		$I_{OL} = 8 \text{ mA}$					0.35	0.5	
I_I	Input current at maximum input voltage	CLR, SET9 $V_{CC} = \text{MAX}, V_I = 7 \text{ V}$			0.1			0.1	mA
		CLK $V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$			0.2			0.2	
I_{IH}	High-level input current	CLR, SET9 $V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$			20			20	μA
		CLK			100			100	
I_{IL}	Low-level input current	CLR, SET9 $V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$			-0.4			-0.4	mA
		CLK			-1.6			-1.6	
I_{OS}^{\S}	Short-circuit output current	$V_{CC} = \text{MAX}$	-20		-100	-20		-100	mA
I_{CC}	Supply current	$V_{CC} = \text{MAX},$ See Note 3		15	26		15	26	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time, and duration of the short circuit should not exceed one second.

NOTE 3: I_{CC} is measured with all outputs open, both CLR inputs grounded following momentary connection to 4.5 V, and all other inputs grounded.

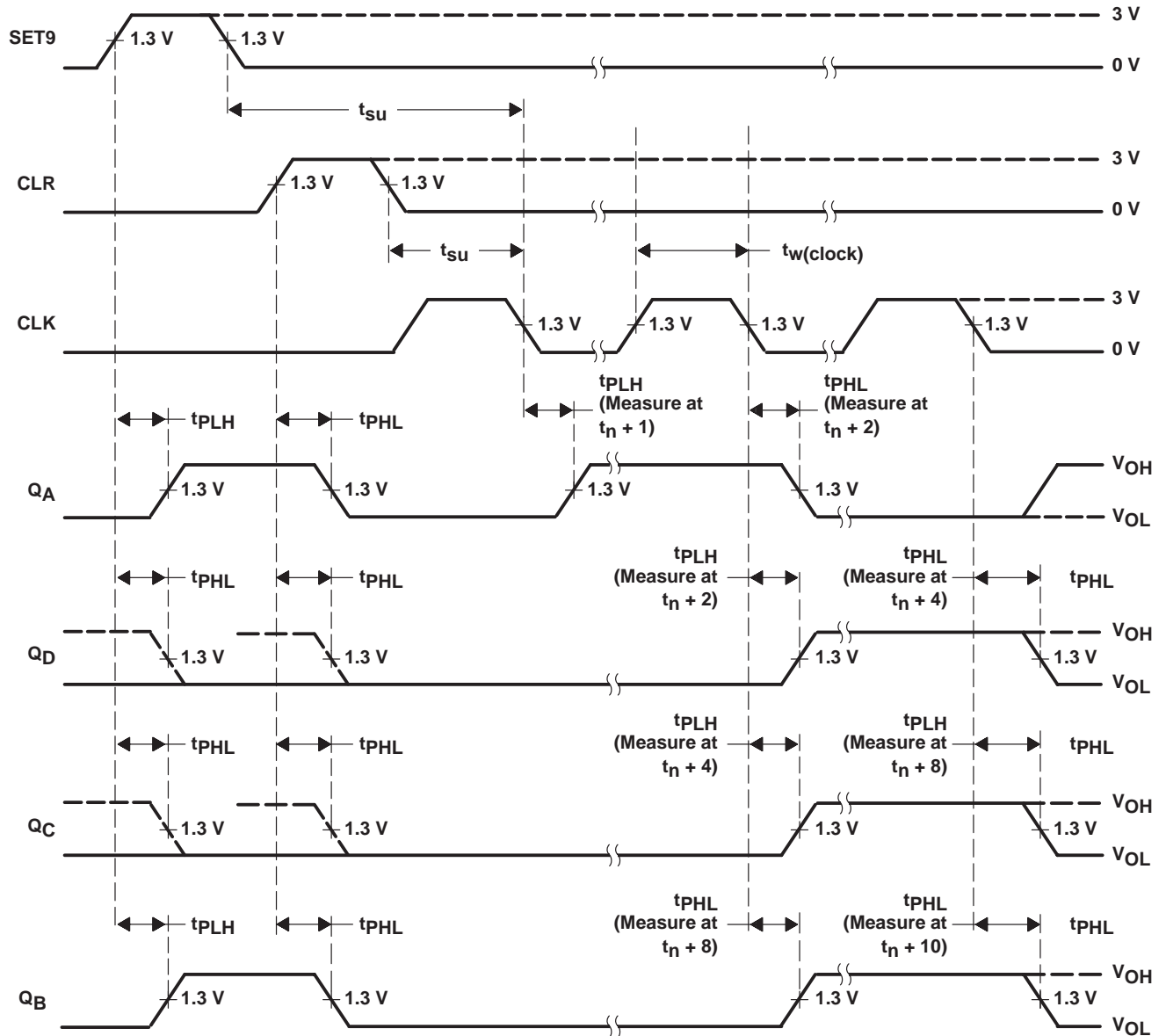
switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see Figures 1 and 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max}	CLK	Q_A	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$	25	35		MHz
t_{PLH}	CLK	Q_A	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$		12	20	ns
t_{PHL}					13	20	
t_{PLH}	CLK	Q_B, Q_D	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$		24	39	ns
t_{PHL}					26	39	
t_{PLH}	CLK	Q_C	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$		32	54	ns
t_{PHL}					36	54	
t_{PHL}	CLR	Any	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$		24	39	ns
t_{PLH}	SET9	Q_A, Q_D	$C_L = 15 \text{ pF}, R_L = 2 \text{ k}\Omega$		24	39	ns
t_{PHL}		Q_B, Q_C			20	36	

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PARAMETER MEASUREMENT INFORMATION



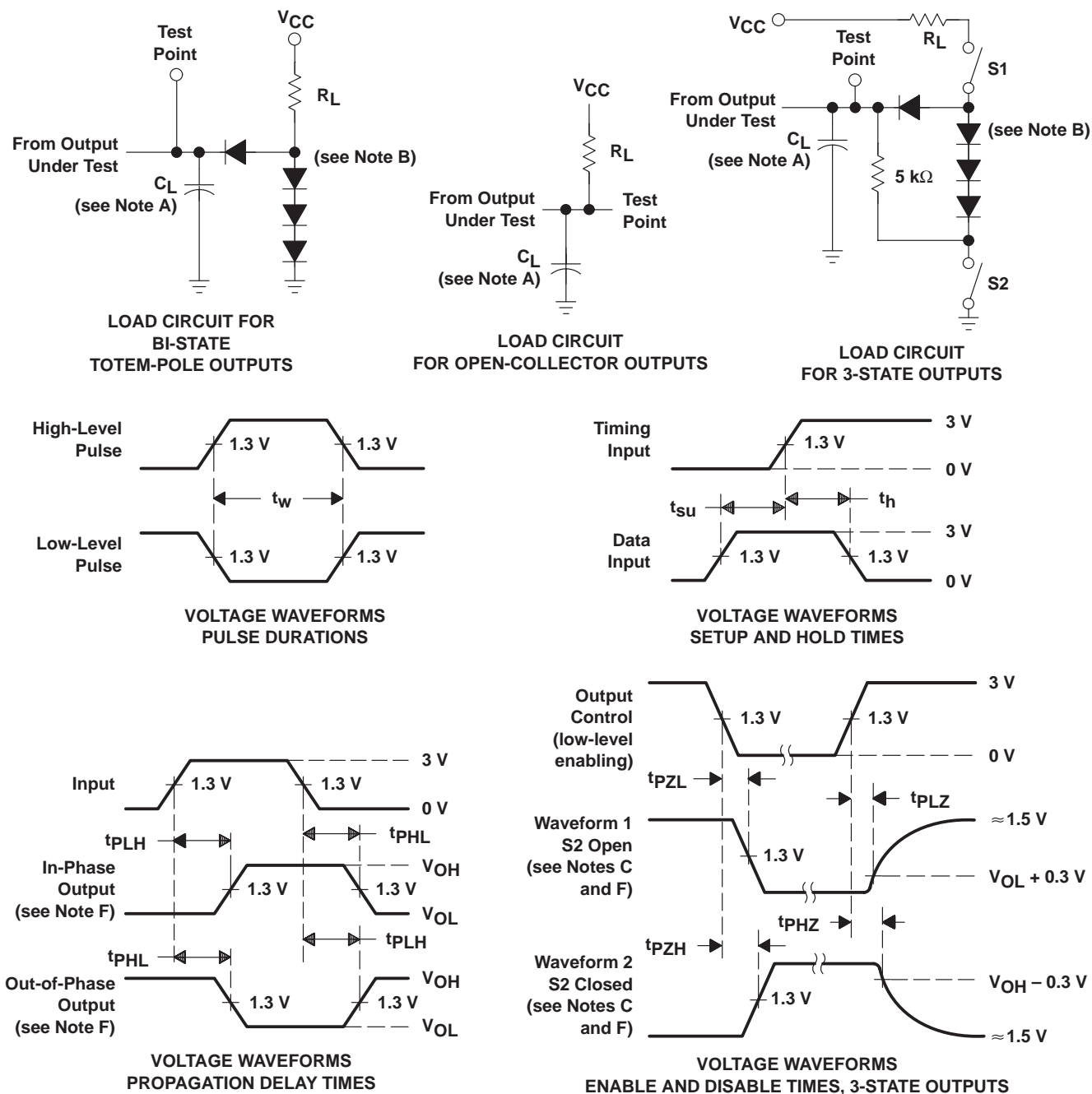
NOTE A: Input pulses are supplied by a generator having the following characteristics: $t_r \leq 15$ ns, $t_f \leq 6$ ns, PRR ≤ 1 MHz, duty cycle = 50%, $Z_O \approx 50 \Omega$.

Figure 1. Voltage Waveforms

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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
 B. All diodes are 1N3064 or equivalent.
 C. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 D. In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.
 E. All input pulses are supplied by generators having the following characteristics: $PRR \leq 1$ MHz, $Z_O \approx 50 \Omega$, $t_r \leq 15$ ns, $t_f \leq 6$ ns.
 F. S1 and S2 are closed for t_{PLH} , t_{PHL} , t_{PHZ} , and t_{PLZ} ; S1 is open and S2 is closed for t_{PZH} ; S1 is closed and S2 is open for t_{PZL} .
 G. The outputs are measured one at a time with one input transition per measurement.

Figure 2. Load Circuits and Voltage Waveforms

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